TMS2708, TMS27L08, SMJ2708, SMJ27L08 1024-Word by 8-Bit Erasable programmable read-only memories

TMS2708 . . . JL PACKAGE SMJ2708 . . . J PACKAGE

DECEMBER 1979 - REVISED AUGUST 1983

1024 X 8 Organization

MOS

LSI

- All Inputs and Outputs Fully TTL Compatible
- Static Operation (No Clocks, No Refresh)
- Max Access/Min Cycle Time

2708-35	350 ns
2708-45	450 ns
27L08-45	450 ns

- 3-State Outputs for OR-Ties
- N-Channel Silicon-Gate Technology
- 8-Bit Output for Use in Microprocessor-Based Systems
- Power Dissipation

'27L08	580	mW	Max	Active
'2708	800	mW	Max	Active

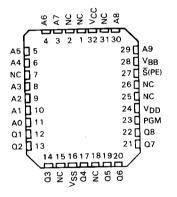
- 10% Power Supply Tolerance (TMS27L08-45 and all SMJ' versions)
- Plug-Compatible Pin-Outs Allowing Interchangeability/Upgrade to 16K With Minimum Board Change
- Available in Full Military Temperature Range Versions (SMJ2708)

description

The '2708-35, '2708-45, and '27L08-45 are ultraviolet light-erasable, electrically programmable read-only memories. They have 8,192 bits organized as 1024 words of 8-bit length. The devices are fabricated using N-channel silicon-gate technology for high speed and simple interface with MOS and bipolar circuits. All inputs (including program data inputs) can be driven by Series 54/74 TTL circuits without the use of external pull-up resistors. Each output can drive one Series 54/74 or 54LS/74LS TTL circuit without external resistors. The '27L08 guarantees 200 mV dc noise immunity in the high state and 250 mV in the low state. The data outputs for the '2708-35, '2708-45, and '27L08-45 are three-state for OR-tying multiple devices on a common bus.

(T	OP \	/IEW)	1
A7 🖸	1 C	724]Vcc
A6 🗌	2	23] A8
A5 🗋	3	22] A9
A4 🗋	4	21]∨ _{BB}
A3 🗋	5	20	S(PE)
A2 🖸	6	19	
A1 🗍	7	18] PGM
A0 🗌	8	17	08
01 🛛	9	16] 07
02 🛛	10	15] 06
Q3 🗌	11	14	05
vss 🗋	12	13	04

SMJ2708 . . . FE PACKAGE (TOP VIEW)



NC - No Connection

P	PIN NOMENCLATURE							
A0-A7	Address Inputs							
NC	No Connection							
PGM	Program							
Q1-Q8	Data Out							
S(PE)	Chip Select/Program Enable							
VBB	- 5-V Power Supply							
Vcc	+ 5-V Power Supply							
VDD	+ 12-V Power Supply							
VSS	0-V Ground							

TMS2708, TMS27L08 SMJ2708, SMJ27L08 1024-Word by 8-bit erasable programmable read-only memories

These EPROMs are designed for high-density fixed-memory applications where fast turn arounds and/or program changes are required. The TMS' Series is supplied in a 24-pin dual-in-line ceramic cerdip (JL suffix) package designed for insertion in mounting-hole rows on 600-mil (15.2 mm) centers. They are designed for operation from 0°C to 70°C.

The SMJ' Series is offered in a 24-pin dual-in-line ceramic package (J) and also in a 32-pin leadless ceramic chip carrier (FE). The J package is designed for insertion in mounting-hole rows on 600-mil (15.2 mm) centers whereas the FE package is intended for surface mounting on solder pads on 0.05-inch (1.27 mm) centers. The FE package is a three-layer 32-pad rectangular chip carrier with dimensions of $0.450 \times 0.550 \times 0.100$ inches (11.43 × 13.97 × 2.54 mm). This series is designed for operation from -55 °C to 125 °C.

operation (read mode)

address (A0-A9)

The address-valid interval determines the device cycle time. The 10-bit positive-logic address is decoded on-chip to select one of the 1024 words of 8-bit length in the memory array. A0 is the least-significant bit and A9 is the most-significant bit of the word address.

chip select, program enable [S (PE)]

When the chip select is low, all eight outputs are enabled and the eight-bit addressed word can be read. When the chip select is high, all eight outputs are in a high-impedance state.

data out (Q1-Q8)

The chip must be selected before the eight-bit output word can be read. Data will remain valid until the address is changed or the chip is deselected. When deselected, the three-state outputs are in a high-impedance state. The outputs will drive TTL circuits without external components.

program

The program pin must be held below VCC in the read mode.

operation (program mode)

erase

Before programming, the '2708-35, '2708-45, or '27L08-45 is erased by exposing the chip through the transparent lid to high-intensity ultraviolet light that has a wavelength of 253.7 nanometers (2537 Angstroms). The recommended minimum exposure dose (UV intensity × exposure time) is fifteen watt-seconds per square centimeter. Thus, a typical 12 milliwatt per square centimeter, filterless UV lamp will erase the device in a minimum of 21 minutes. The lamp should be located about 2.5 centimeters (1 inch) above the chip during erasure. After erasure, all bits are in the high state.

programming

Programming consists of successively depositing a small amount of charge to a selected memory cell that is to be changed from the erased high state to the low state. A low can be changed to a high only by erasure. Programming is normally accomplished on a PROM or EPROM Programmer, an example of which is TI's Universal PROM Programming Module in conjunction with the 990 prototyping system. Programming must be done at room temperature (25 °C) only.

to start programming (see program cycle timing diagram)

First bring the \overline{S} (PE) pin to +12 V to disable the outputs and convert them to inputs. This pin is held high for the duration of the programming sequence. The first word to be programmed is addressed (it is customary to begin with the "0" address) and the data to be stored is placed on the Q1-Q8 program inputs. Then a +25 V program pulse is applied to the program pin. After 0.1 to 1.0 milliseconds the program pin is brought back to 0 V. After at least one microsecond the word address is sequentially changed to the next location, the new data is set up and the program pulse is applied.

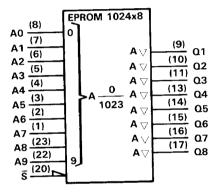
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Programming continues in this manner until all words have been programmed. This constitutes one of N program loops. The entire sequence is then repeated N times with $N \times t_W(PR) \ge 100$ ms. Thus, if $t_W(PR) = 1$ ms; then N = 100, the minimum number of program loops required to program the EPROM.

to stop programming

After cycling through the N program loops, the last program pulse is brought to 0 V, then Program Enable [\overline{S} (PE)] is brought to V_{IL} which takes the device out of the program mode. The data supplied by the programmer must be removed before the address is changed since the program inputs are now data outputs and change of address could cause a voltage conflict on the output buffer. Q1-Q8 outputs are invalid up to 10 microseconds after the program enable pin is brought from VIH(PE) to VIL.

logic symbol[†]



[†]This symbol is in accordance with IEEE Std 91/ANSI Y32.14 and recent decisions in IEEE and IEC. See explanation on page 10-1.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage, VBB (see Note 1)	– 0.3 V to 7 V
Supply voltage, VBB (see Note 1)	-0.3 V to 15 V
Supply voltage, VBB (see Note 1)	-0.3 V to 20 V
and the second	. 0.0
Supply voltage, VSS (see Note 17)	0.3 V to 20 V
Supply voltage, VSS (see Note 1) All input voltage (except program) (see Note 1)	-0.3 V to 35 V
All input voltage (except program) (see Note 1)	_ 2 V to 7 V
i = i with respect to VCC)	2
Operating free-air temperature range: TMS'	0°C to 70°C
Operating free-air temperature range: 1993	-65°C to 150°C
Operating case temperature range: SMJ'	
Operating case temperature of	– 55°C to 125°C
Operating case temperature range. Swith the second	

* Stresses beyond those listed under ''Absolute Maximum Ratings'' may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the ''Recommended Operating Conditions'' section of this specification is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Under absolute maximum ratings, voltage values are with respect to the most-negative supply voltage. VBB (substrate), unless otherwise noted. Throughout the remainder of this data sheet, voltage values are with respect to VSS.

TMS2708, TMS27L08 1024-WORD BY 8-BIT ERASABLE PROGRAMMABLE READ-ONLY MEMORIES

recommended operating conditions

PARAMETER	Т	TM	UNIT				
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, VBB	- 4.75	- 5	- 5.25	-4.5	- 5	- 5.5	v
Supply voltage, VCC	4.75	5	5.25	4.5	5	5.5	1 v
Supply voltage, VDD	11.4	12	12.6	10.8	12	13.2	t v
Supply voltage VSS		0			0	10.2	1 v
High-level input voltage, VIH							<u> </u>
(except program and program enable)	2.4		V _{CC} + 1	2.2		Vcc+1	
High-level program enable input voltage, VIH(PE)	11.4	12	12.6	10.8	12	13.2	V
High-level program input voltage, VIH(PR)	25	26	27	25	26	27	v
Low-level input voltage, VIL (except program)	Vss		0.65	Vss		0.65	v
Low-level program input voltage, VIL(PB)				.55		0.05	<u> </u>
Note: $V_{IL}(PR)$ max $\leq V_{IH}(PR) - 25 V$	V _{SS}		1	VSS		1	v
High-level program pulse input current (sink), I(H(PB)			40	··		40	mA
Low-level program pulse input current (source), ILL(PR)			3			- 40	mA
Operating free-air temperature, TA	0		70	0		70	•C

electrical characteristics over full ranges of recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	1	MS2708 MS2708		τN	IS27L08	-45	UNIT
			MIN	TYP	MAX	MIN	TYP [†]	MAX	1
VOH	High-level output voltage	$I_{OH} = -100 \mu A$	3.7			3.7			
		$I_{OH} = -1 \text{ mA}$	2.4			2.4			V V
VOL	Low-level output voltage	I _{OL} = 1.6 mA			0.45			0.40	v
4	Input current (leakage)	$V_{\rm I} = 0 V \text{ to } 5.25 V$		1	10		1	10	μA
lo	Output current (leakage)	S (PE) = 5 V,	-	1		_	1	10	μA
·0		$V_0 = 0.4 V$ to 5.25 V			10				
IBB	Supply current from VBB	All inputs high,		30	45		9	18	mA
lcc	Supply current from VCC	Ŝ(PE) ≈ 5 V,		6	10		0.9		mA
	Supply current from VDD	T _A = °C					_		<u> </u>
.00	Coppiy current noin VDD	(worst case)		50	65		20	34	mA
		T _A = 70°C			800			350	
PD(AV)	Power Dissipation	$T_A = 0 \circ C, \overline{S} = 0 V$					245	475	m₩
		$T_{A} = 0 ^{\circ}C, \overline{S} = +5 V$					290	580	1

capacitance over recommended supply voltage range and operating free-air temperature range, f = 1 MHz^{\dagger}

	PARAMETER	T۸	AS'	
		TYP [‡]	MAX	UNIT
Ci	Input capacitance	4	6	pF
C _o	Output capacitance	8	12	pF

[†]This parameter is tested on sample basis only.

¹All typical values are at $T_A = 25 \,^{\circ}C$ and nominal voltages.

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EPROM Devices

TMS2708, TMS27L08 1024-WORD BY 8-BIT ERASABLE PROGRAMMABLE READ-ONLY MEMORIES

	PARAMETER TEST CONDITIONS		TMS2	708-35		2708 27L08	UNIT
	PARAMETER		MIN	MAX	MIN	MAX	1
1-101	Access time from Address			350		450	ns
t _{a(A)} t _{a(S)}	Access time from S	C _L = 100 pF		120		120	ns
^t v(A)	Output data valid after address change	1 Series 54/74 TTL load	o		0		ns
tdis	Output disable time [†]	$t_{f(S)}, t_{f(A)} = 20 \text{ ns}$	0	120	0	120	ns
t _{c(rd)}	Read cycle time		350		450		ns

switching characteristics over recommended supply voltage range and operating free-air temperature range

[†]Value calculated from 0.5 volt delta to measured output level.

recommended timing requirements for programming $T_A = 25 \,^{\circ}C$

	TN	NS'	UNIT
PARAMETER	MIN	MAX	
Pulse duration, program pulse	0.1	1	ms
		20	ns
		2000	ns
			μS
	10		μS
	10		μs
Address hold time	1000		ns
Address hold time after program input data stopped	0		ns
			ns
	500		ns
Delay time, S(PE) low to address change	0		กร
	Pulse duration, program pulse Transition times (except program pulse) Transition times, program pulse Address setup time Data setup time Program enable setup time Address hold time Address hold time after program input data stopped Data hold time Program enable hold time	PARAMETER MIN Pulse duration, program pulse 0.1 Transition times (except program pulse) 50 Address setup time 10 Data setup time 10 Program enable setup time 10 Address hold time 100 Address hold time 1000 Porgram enable hold time 500	Pulse duration, program pulse 0.1 1 Transition times (except program pulse) 20 Transition times, program pulse 50 2000 Address setup time 10 Data setup time 10 Address hold time 100 Address hold time after program input data stopped 0 Data hold time 1000

SMJ2708, SMJ27L08 1024-WORD BY 8-BIT ERASABLE PROGRAMMABLE READ-ONLY MEMORIES

PARAMETER	SMJ2708-35 SMJ2708-45			SN			
	MIN	NOM	MAX	MIN	NOM	MAX	1
Supply voltage, VBB	- 4.75	- 5	-5.25	- 4.5	- 5	- 5.5	V
Supply voltage, V _{CC}	4.75	5	5.25	4.5	5	5.5	v
Supply voltage, VDD	11.4	12	12.6	10.8	12	13.2	V
Supply voltage VSS		0		-	0		V
High-level input voltage, VIH							
(except program and program enable	2.4		V _{CC} + 1	2.2		V _{CC} + 1	
High-level program enable input voltage, VIH(PE)	11.4	12	12.6	10.8	12	13.2	V
High-level program input voltage, VIH(PR)	25	26	27	25	26	27	V
Low-level input voltage, VIL (except program)	VSS		0.65	VSS		0.65	v
Low-level program input voltage, $V_{IL(PR)}$ Note: $V_{IL(PR)}$ max $\leq V_{IH(PR)} - 25 V$	V _{SS}		1	VSS		1	v
High-level program pulsle input current (sink), IIH(PR)			40			40	mA
Low-level program pulse input current (source), IIL(PR)			3			3	mA
Operating case temperature, TC	- 55		125	- 55		125	°C

recommended operating conditions

electrical characteristics over full ranges of recommended operating conditions (unless otherwise noted)

	PARAMETER TEST CONDITION		SMJ2708-35 SMJ2708-45			SMJ27L08-45			UNIT
			MIN	TYP [†]	MAX	MIN	TYP [†]	MAX	
Vон	High-level output voltage	$I_{OH} = -100 \ \mu A$	3.7			3.7			
*OH		$I_{OH} = -1 \text{ mA}$	2.4	•		2.4			l v
VOL	Low-level output voltage	$I_{OL} = 1.6 \text{ mA}$			0.45			0.40	V
t <u>r</u>	Input current (leakage)	$V_{I} = 0 V \text{ to } 5.25 V$		1	10		1	10	μA
lo	Output current (leakage)	\overline{S} (PE) = 5 V, V _O = 0.4 V to 5.5 V		1	10		1	10	μΑ
^I BB	Supply current from VBB		-	30	45		9	18	mA
lcc	Supply current from V _{CC}	All inputs high,		6	10		0.9	6	mA
IDD	Supply current from VDD	- Š(PE) = 5 V,	-	50	65		20	34	mA

capacitance over recommended supply voltage range and operating case temperature range, f = 1 MHz †

	PARAMETER		SMJ′	
		TYP‡	MAX	UNIT
Ci	Input capacitance	4	6	pF
Co	Output capacitance	8	12	pF

 $^{\dagger} {\rm This}$ parameter is tested on sample basis only.

[‡]All typical values are at T_C = 25 °C and nominal voltages.

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SMJ2708, SMJ27L08 1024-WORD BY 8-BIT ERASABLE PROGRAMMABLE READ-ONLY MEMORIES

switching characteristics over recommended supply voltage range and operating case temperature range

PARAMETER		TEST CONDITIONS	SMJ2708-35		SMJ2708 SMJ27L08		UNIT
			MIN	MAX	MIN	MAX	
t _{a(A)}	Access time from Address			350		450	ns
ta(S)	Access time from S	$C_L = 100 \text{ pF}$		120		120	ns
t _{v(A)}	Output data valid after address change	1 Series 54/74 TTL load	0		0		ns
tdis	Output disable time [†]	$t_{f(S)}, t_{f(A)} = 20 \text{ ns}$	0	120	0	120	ns
t _{c(rd)}	Read cycle time		350		450		ns

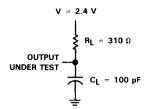
[†]Value calculated from 0.5 volt delta to measured output level.

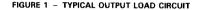
recommended timing requirements for programming $T_C = 25 \,^{\circ}C$

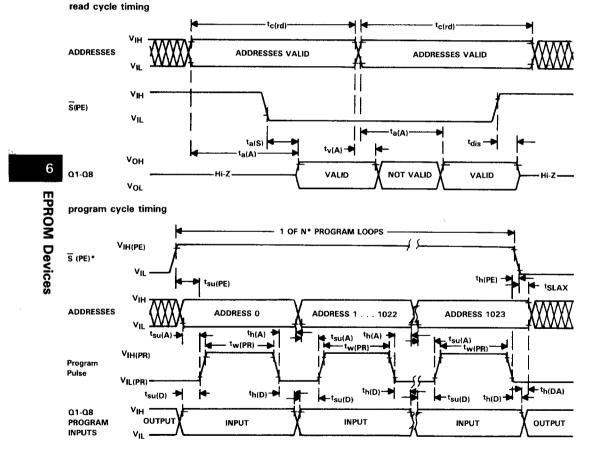
			SMJ'	
	PARAMETER	MIN	MAX	UNIT
tw(PR)	Pulse duration, program pulse	0.1	1	ms
t _t	Transition times (except program pulse)		20	ns
t _t (PR)	Transition times, program pulse	50	2000	ns
t _{su(A)}	Address setup time	10		μS
t _{su(D)}	Data setup time	10		μS
t _{su} (PE)	Program enable setup time	10		μS
^t h(A)	Address hold time	1000		ns
th(DA)	Address hold time after program input data stopped	0		ns
th(D)	Data hold time	1000		ns
th(PE)	Program enable hold time	500		ns
tSLAX	Delay time, S(PE) low to address change	0		ns

TMS2708, TMS27L08 SMJ2708, SMJ27L08 1024-WORD BY 8-BIT ERASABLE PROGRAMMABLE READ-ONLY MEMORIES

PARAMETER MEASUREMENT INFORMATION







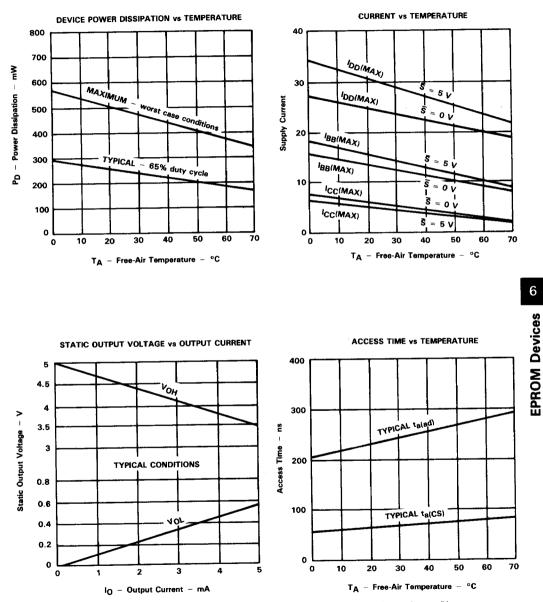
 $^{*}\overline{S}$ (PE) is at +12 V through N program loops where N <100 ms/tw (PR). NOTE: Q1-Q8 outputs are invalid up to 10 µsec after programming (\overline{S} (PE) goes low). All timing reference points in this data sheet (inputs and outputs) are 90% points.

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TMS2708, TMS27L08 SMJ2708, SMJ27L08 1024-Word by 8-bit erasable programmable read-only memories

TYPICAL '27L08-45 CHARACTERISTICS



Texas Instruments reserves the right to make changes at any time in order to improve design and to supply the best product possible.

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